Notice of References Cited

Application/Control No. 10/783,104	Applicant(s)/Pater Reexamination KAHN ET AL.			
Examiner	Art Unit			
ROBERT HANCE	4134	Page 1 of 1		

II S PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0006404	07-2001	Yun, Hwa Young	348/553
*	В	US-4,776,038	10-1988	Testin et al.	455/182.3
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	jp2002344838	11-2002	Japan	Inui et al.	
	0					
	Р					
	Q					
	R					
	s					
	т					

NON DATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
Ī	U	model de application, realizer, realizer, a demonstra Estation of Youther, relational august	
	v		
	w		
	x		

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.